



SBOS307F-MAY 2004-REVISED FEBRUARY 2010

# CURRENT SHUNT MONITOR -16V to +80V Common-Mode Range

Check for Samples: INA193, INA194, INA195, INA196, INA197, INA198

### FEATURES

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- WIDE COMMON-MODE VOLTAGE: -16V to +80V
- LOW ERROR: 3.0% Over Temp (max)
- BANDWIDTH: Up to 500kHz
- THREE TRANSFER FUNCTIONS AVAILABLE: 20V/V, 50V/V, and 100V/V
- QUIESCENT CURRENT: 900µA (max)
- COMPLETE CURRENT SENSE SOLUTION

### **APPLICATIONS**

- WELDING EQUIPMENT
- NOTEBOOK COMPUTERS
- CELL PHONES
- TELECOM EQUIPMENT
- AUTOMOTIVE
- POWER MANAGEMENT
- BATTERY CHARGERS

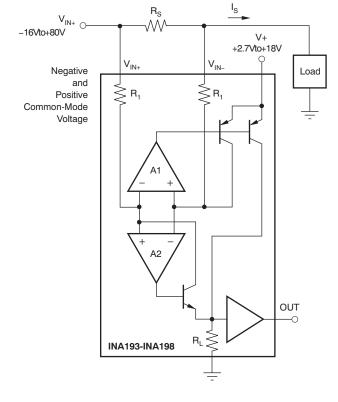
### DESCRIPTION

The INA193–INA198 family of current shunt monitors with voltage output can sense drops across shunts at common-mode voltages from -16V to +80V, independent of the INA19x supply voltage. They are available with three output voltage scales: 20V/V, 50V/V, and 100V/V. The 500kHz bandwidth simplifies use in current control loops. The INA193–INA195 provide identical functions but alternative pin configurations to the INA196–INA198, respectively.

The INA193–INA198 operate from a single +2.7V to +18V supply, drawing a maximum of  $900\mu$ A of supply current. They are specified over the extended operating temperature range (-40°C to +125°C), and are offered in a space-saving SOT23 package.

MODEL	GAIN	PACKAGE	PINOUT <sup>(1)</sup>
INA193	20V/V	SOT23-5	Pinout #1
INA194	50V/V	SOT23-5	Pinout #1
INA195	100V/V	SOT23-5	Pinout #1
INA196	20V/V	SOT23-5	Pinout #2
INA197	50V/V	SOT23-5	Pinout #2
INA198	100V/V	SOT23-5	Pinout #2

(1) See *Pin Assignments* for Pinout #1 and Pinout #2.



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### INA193, INA194 INA195, INA196 INA197, INA198



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

PRODUCT	PACKAGE-LEAD	PACKAGE DESIGNATOR	PACKAGE MARKING					
INA193	SOT23-5	DBV	BJJ					
INA194	SOT23-5	DBV	BJI					
INA195	SOT23-5	DBV	BJK					
INA196	SOT23-5	DBV	BJE					
INA197	SOT23-5	DBV	BJH					
INA198	SOT23-5	DBV	BJL					

### PACKAGE INFORMATION<sup>(1)</sup>

(1) For the most current package and ordering information see the Package Option Addendum at the end of this document, or see the TI web site at www.ti.com.

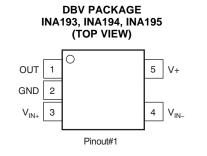
### ABSOLUTE MAXIMUM RATINGS<sup>(1)</sup>

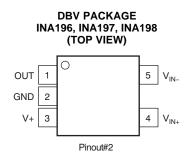
		INA19x	UNIT
Supply Voltage		+18	V
Analog Inputs, V <sub>II</sub> Differential (V <sub>IN+</sub> )	<sub>N+</sub> , V <sub>IN-</sub> - (V <sub>IN-</sub> )	-18 to +18	V
Common-Mode <sup>(2)</sup>		-16 to +80	V
Analog Output, O	ut <sup>(2)</sup>	GND – 0.3 to (V+) + 0.3	V
Input Current Into	Any Pin <sup>(2)</sup>	5	mA
Operating Tempe	rature	-55 to +150	°C
Storage Tempera	ture	-65 to +150	°C
Junction Temperature		+150	°C
ESD Ratings	Human Body Model (HBM)	4000	V
	Charged-Device Model (CDM)	1000	V

(1) Stresses above these ratings may cause permanent damage. Exposure to absolute maximum conditions for extended periods may degrade device reliability. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those specified is not supported.

(2) Input voltage at any pin may exceed the voltage shown if the current at that pin is limited to 5mA.

### **PIN ASSIGNMENTS**







### ELECTRICAL CHARACTERISTICS: V<sub>s</sub> = +12V

**Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ . All specifications at  $T_A = +25^{\circ}C$ ,  $V_S = +12V$ ,  $V_{IN+} = 12V$ , and  $V_{SENSE} = 100$ mV, unless otherwise noted.

			INA193, INA194, INA195, INA196, INA197, INA198				
PARAMETER		TEST CONDITIONS	MIN	ТҮР	MAX	UNIT	
INPUT							
Full-Scale Input Voltage	$V_{\text{SENSE}}$	$V_{SENSE} = V_{IN+} - V_{IN-}$		0.15	(V <sub>S</sub> – 0.2)/Gain	V	
Common-Mode Input Range	V <sub>CM</sub>		-16		80	v	
Common-Mode Rejection	CMR	$V_{IN+} = -16V$ to +80V	80	94		dB	
Over Temperature		V <sub>IN+</sub> = +12V to +80V	100	120		dB	
Offset Voltage, RTI	V <sub>OS</sub>			±0.5	2	mV	
Over Temperature				0.5	3	mV	
vs Temperature	dV <sub>os</sub> /dT			2.5		μ <b>V/°C</b>	
vs Power Supply	PSR	$V_{S} = +2.7V$ to +18V, $V_{IN+} = +18V$		5	100	μ <b>V/V</b>	
Input Bias Current, V <sub>IN-</sub> pin	I <sub>B</sub>			±8	±16	μΑ	
OUTPUT (V <sub>SENSE</sub> ≥ 20mV)							
Gain: INA193, INA196	G			20		V/V	
Gain: INA194, INA197				50		V/V	
Gain: INA195, INA198				100		V/V	
Gain Error		$V_{SENSE}$ = 20mV to 100mV, $T_A$ = +25°C		±0.2	±1	%	
Over Temperature		V <sub>SENSE</sub> = 20mV to 100mV			±2	%	
Total Output Error <sup>(1)</sup>		V <sub>SENSE</sub> = 100mV		±0.75	±2.2	%	
Over Temperature				±1	±3	%	
Nonlinearity Error		V <sub>SENSE</sub> = 20mV to 100mV		±0.002	±0.1	%	
Output Impedance	Ro			1.5		Ω	
Maximum Capacitive Load		No Sustained Oscillation		10		nF	
OUTPUT (V <sub>SENSE</sub> < 20mV) <sup>(2)</sup>							
All Devices		$-16V \le V_{CM} < 0V$		300		mV	
INA193, INA196		$0V \le V_{CM} \le V_S, V_S = 5V$			0.4	V	
INA194, INA197		$0V \le V_{CM} \le V_S, V_S = 5V$			1	V	
INA195, INA198		$0V \le V_{CM} \le V_S, V_S = 5V$			2	V	
All Devices		$V_{\rm S} < V_{\rm CM} \le 80V$		300		mV	
VOLTAGE OUTPUT <sup>(3)</sup>		$R_L = 100k\Omega$ to GND					
Swing to V+ Power-Supply Rail				(V+) – 0.1	(V+) – 0.2	v	
Swing to GND <sup>(4)</sup>				(V <sub>GND</sub> ) + 3	(V <sub>GND</sub> ) + 50	mV	
FREQUENCY RESPONSE							
Bandwidth, INA193, INA196	BW	$C_{LOAD} = 5pF$		500		kHz	
Bandwidth, INA194, INA197		$C_{LOAD} = 5pF$		300		kHz	
Bandwidth, INA195, INA198		$C_{LOAD} = 5pF$		200		kHz	
Phase Margin		$C_{LOAD} < 10nF$		40		degrees	
Slew Rate	SR			1		V/µs	
Settling Time (1%)	ts	$V_{SENSE} = 10mV$ to $100mV_{PP}$ , $C_{LOAD} = 5pF$		2		μS	
NOISE, RTI							
Voltage Noise Density				40		nV/√ <del>Hz</del>	

(1)

Total output error includes effects of gain error and V<sub>OS</sub>. For details on this region of operation, see the *Accuracy Variations* section in the *Applications Information*. (2)

(3) (4) See Typical Characteristic curve Output Swing vs Output Current, Figure 7.

Specified by design.



### ELECTRICAL CHARACTERISTICS: V<sub>s</sub> = +12V (continued)

**Boldface** limits apply over the specified temperature range,  $T_A = -40^{\circ}C$  to  $+125^{\circ}C$ . All specifications at  $T_A = +25^{\circ}C$ ,  $V_S = +12V$ ,  $V_{IN+} = 12V$ , and  $V_{SENSE} = 100$ mV, unless otherwise noted.

PARAMETER			INA193, INA194	INA193, INA194, INA195, INA196, INA197, INA198				
		TEST CONDITIONS	MIN	TYP	MAX	UNIT		
POWER SUPPLY								
Operating Range	Vs		+2.7		+18	v		
Quiescent Current	Ι <sub>Q</sub>	$V_{OUT} = 2V$		700	900	μA		
Over Temperature		V <sub>OUT</sub> = 2V V <sub>SENSE</sub> = 0mV		370	950	μΑ		
TEMPERATURE RANGE								
Specified Temperature Range			-40		+125	°C		
Operating Temperature Range			-55		+150	°C		
Storage Temperature Range			-65		+150	°C		
Thermal Resistance, SOT23	$\theta_{JA}$			200		°C/W		

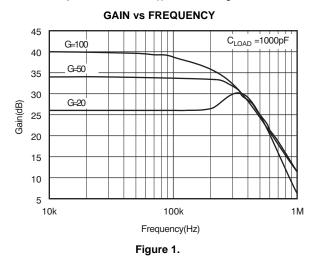
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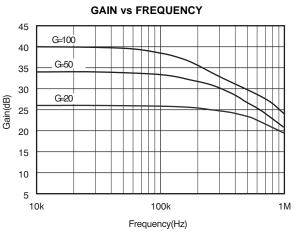


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### **TYPICAL CHARACTERISTICS**

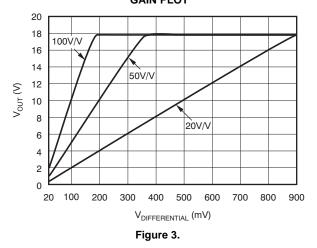
All specifications at  $T_A = +25^{\circ}$ C,  $V_S = +12$ V, and  $V_{IN+} = 12$ V, and  $V_{SENSE} = 100$ mV, unless otherwise noted.







GAIN PLOT



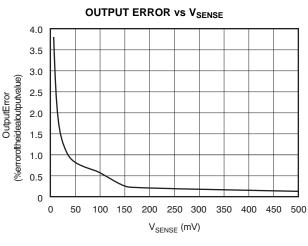
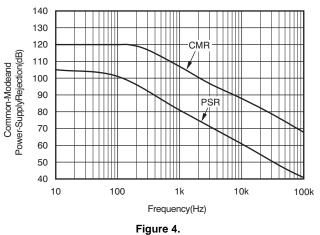
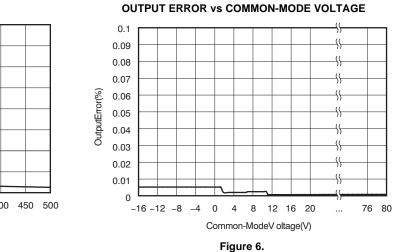


Figure 5.

COMMON-MODE AND POWER-SUPPLY REJECTION vs FREQUENCY





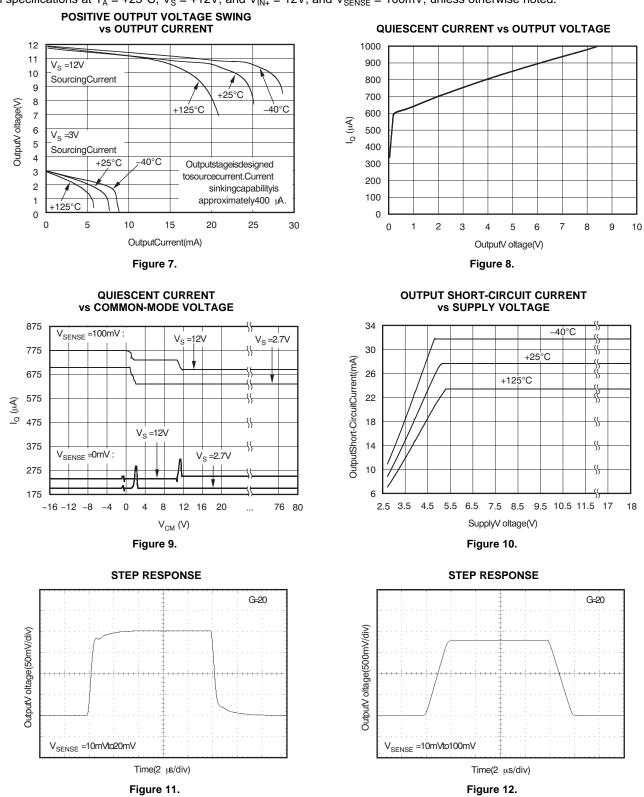
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### **TYPICAL CHARACTERISTICS (continued)**

All specifications at  $T_A = +25^{\circ}C$ ,  $V_S = +12V$ , and  $V_{IN+} = 12V$ , and  $V_{SENSE} = 100mV$ , unless otherwise noted.



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Product Folder Link(s): INA193 INA194 INA195 INA196 INA197 INA198

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### **TYPICAL CHARACTERISTICS (continued)**

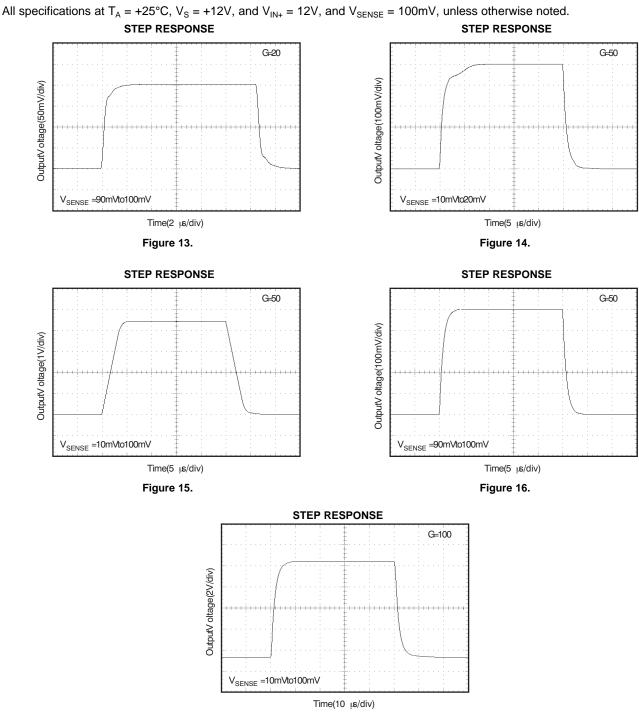


Figure 17.



### **APPLICATIONS INFORMATION**

### **BASIC CONNECTION**

Figure 18 shows the basic connection of the INA193-INA198. The input pins,  $V_{IN+}$  and  $V_{IN-}$ , should be connected as closely as possible to the shunt resistor to minimize any resistance in series with the shunt resistance.

Power-supply bypass capacitors are required for stability. Applications with noisy or high impedance power supplies may require additional decoupling capacitors to reject power-supply noise. Connect bypass capacitors close to the device pins.

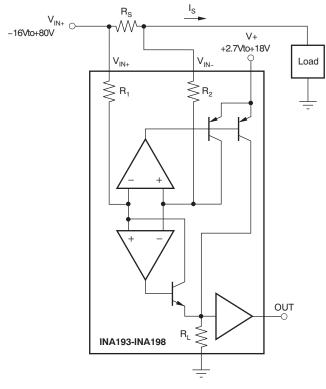


Figure 18. INA193-INA198 Basic Connection

### **POWER SUPPLY**

The input circuitry of the INA193-INA198 can accurately measure beyond its power-supply voltage, V+. For example, the V+ power supply can be 5V, whereas the load power-supply voltage is up to +80V. The output voltage range of the OUT terminal, however, is limited by the voltages on the power-supply pin.

# ACCURACY VARIATIONS AS A RESULT OF V<sub>SENSE</sub> AND COMMON-MODE VOLTAGE

The accuracy of the INA193–INA198 current shunt monitors is a function of two main variables:  $V_{SENSE}$  ( $V_{IN+} - V_{IN-}$ ) and common-mode voltage,  $V_{CM}$ , relative to the supply voltage,  $V_S$ .  $V_{CM}$  is expressed as ( $V_{IN+} + V_{IN-}$ )/2; however, in practice,  $V_{CM}$  is seen as the voltage at  $V_{IN+}$  because the voltage drop across  $V_{SENSE}$  is usually small.

This section addresses the accuracy of these specific operating regions:

- Normal Case 1:  $V_{SENSE} \ge 20mV$ ,  $V_{CM} \ge V_{S}$
- Normal Case 2:  $V_{SENSE} \ge 20mV$ ,  $V_{CM} < V_{S}$
- Low V<sub>SENSE</sub> Case 1: V<sub>SENSE</sub> < 20mV,  $-16V \le V_{CM} < 0$
- Low V<sub>SENSE</sub> Case 2: V<sub>SENSE</sub> < 20mV, 0V  $\leq$  V<sub>CM</sub>  $\leq$  V<sub>S</sub>
- Low V\_{SENSE} Case 3: V\_{SENSE} < 20mV, V\_S < V\_{CM} \leq 80V

### Normal Case 1: $V_{SENSE} \ge 20mV$ , $V_{CM} \ge V_{S}$

This region of operation provides the highest accuracy. Here, the input offset voltage is characterized and measured using a two-step method. First, the gain is determined by Equation 1.

$$G = \frac{V_{OUT1} - V_{OUT2}}{100 \text{mV} - 20 \text{mV}}$$

where:

$$V_{OUT1}$$
 = Output Voltage with  $V_{SENSE}$  = 100mV

 $V_{OUT2}$  = Output Voltage with  $V_{SENSE}$  = 20mV (1)

e . .

Then the offset voltage is measured at  $V_{SENSE}$  = 100mV and referred to the input (RTI) of the current shunt monitor, as shown in Equation 2.

$$V_{OS}RTI(Referred-To-Input) = \left[\frac{V_{OUT1}}{G}\right] - 100mV$$
 (2)

In the Typical Characteristics, the *Output Error vs Common-Mode Voltage* curve (Figure 6) shows the highest accuracy for this region of operation. In this plot,  $V_S = 12V$ ; for  $V_{CM} \ge 12V$ , the output error is at its minimum. This case is also used to create the  $V_{SENSE} \ge 20mV$  output specifications in the Electrical Characteristics table.

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### Normal Case 2: $V_{SENSE} \ge 20mV$ , $V_{CM} < V_S$

This region of operation has slightly less accuracy than Normal Case 1 as a result of the common-mode operating area in which the part functions, as seen in the *Output Error vs Common-Mode Voltage* curve (Figure 6). As noted, for this graph  $V_S = 12V$ ; for  $V_{CM} < 12V$ , the Output Error increases as  $V_{CM}$  becomes less than 12V, with a typical maximum error of 0.005% at the most negative  $V_{CM} = -16V$ .

# $\begin{array}{l} \text{Low } V_{\text{SENSE}} \text{ Case 1:} \\ V_{\text{SENSE}} < 20 \text{mV}, -16 \text{V} \leq \text{V}_{\text{CM}} < 0; \\ \text{and } \text{Low } V_{\text{SENSE}} \text{ Case 3:} \\ V_{\text{SENSE}} < 20 \text{mV}, \text{V}_{\text{S}} < \text{V}_{\text{CM}} \leq 80 \text{V} \end{array}$

Although the INA193–INA198 family of devices are not designed for accurate operation in either of these regions, some applications are exposed to these conditions; for example, when monitoring power supplies that are switched on and off while  $V_S$  is still applied to the INA193–INA198. It is important to know what the behavior of the devices will be in these regions.

As  $V_{SENSE}$  approaches 0mV, in these  $V_{CM}$  regions, the device output accuracy degrades. A larger-than-normal offset can appear at the current shunt monitor output with a typical maximum value of  $V_{OUT}$  = 300mV for  $V_{SENSE}$  = 0mV. As  $V_{SENSE}$ approaches 20mV,  $V_{OUT}$  returns to the expected output value with accuracy as specified in the Electrical Characteristics. Figure 19 illustrates this effect using the INA195 and INA198 (Gain = 100).

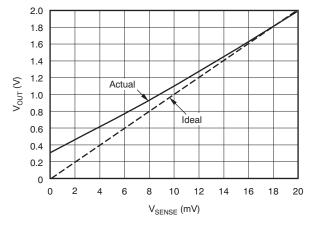


Figure 19. Example for Low V<sub>SENSE</sub> Cases 1 and 3 (INA195, INA198: Gain = 100)

### Low $V_{SENSE}$ Case 2: $V_{SENSE} < 20 \text{mV}$ , $0 \text{V} \le V_{CM} \le V_S$

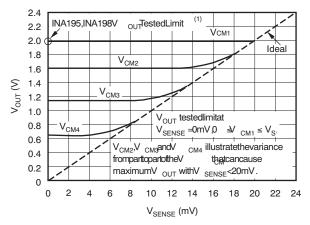
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INA193, INA194

INA195, INA196

INA197. INA198

This region of operation is the least accurate for the INA193-INA198 family. To achieve the wide input common-mode voltage range, these devices use two op amp front ends in parallel. One op amp front end operates in the positive input common-mode voltage range, and the other in the negative input region. For this case, neither of these two internal amplifiers dominates and overall loop gain is very low. Within this region, V<sub>OUT</sub> approaches voltages close to linear operation levels for Normal Case 2. This deviation from linear operation becomes greatest the closer V<sub>SENSE</sub> approaches 0V. Within this region, as V<sub>SENSE</sub> approaches 20mV, device operation is closer to that described by Normal Case 2. Figure 20 illustrates this behavior for the INA195. The  $V_{OUT}$  maximum peak for this case is tested by maintaining a constant  $V_{s}$ , setting  $V_{SENSE} = 0mV$  and sweeping  $V_{CM}$  from 0V to  $V_{S}$ . The exact  $V_{CM}$  at which  $V_{OUT}$  peaks during this test varies from part to part, but the V<sub>OUT</sub> maximum peak is tested to be less than the specified Vour Tested Limit.



(1) INA193, INA196  $V_{OUT}$  Tested Limit = 0.4V. INA194, INA197  $V_{OUT}$  Tested Limit = 1V.

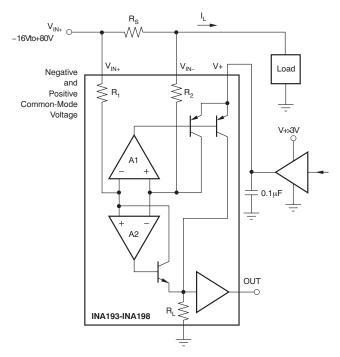
Figure 20. Example for Low V<sub>SENSE</sub> Case 2 (INA195, INA198: Gain = 100)

# INA193, INA194 INA195, INA196 INA197. INA198

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### SHUTDOWN

Because the INA193-INA198 consume a guiescent current less than 1mA, they can be powered by either the output of logic gates or by transistor switches to supply power. Use a totem-pole output buffer or gate that can provide sufficient drive along with 0.1µF bypass capacitor, preferably ceramic with good high-frequency characteristics. This gate should have a supply voltage of 3V or greater because the INA193-INA198 requires a minimum supply greater than 2.7V. In addition to eliminating quiescent current, this gate also turns off the 10µA bias current present at each of the inputs. An example shutdown circuit is shown in Figure 21.



### Figure 21. INA193-INA198 Example Shutdown Circuit

### SELECTING R<sub>s</sub>

The value chosen for the shunt resistor, R<sub>S</sub>, depends on the application and is a compromise between small-signal accuracy and maximum permissible



voltage loss in the measurement line. High values of R<sub>S</sub> provide better accuracy at lower currents by minimizing the effects of offset, while low values of R<sub>S</sub> minimize voltage loss in the supply line. For most applications, best performance is attained with an R<sub>S</sub> value that provides a full-scale shunt voltage range of 50mV to 100mV. Maximum input voltage for accurate measurements is 500mV.

### TRANSIENT PROTECTION

The -16V to +80V common-mode range of the INA193-INA198 is ideal for withstanding automotive fault conditions ranging from 12V battery reversal up to +80V transients, since no additional protective components are needed up to those levels. In the event that the INA193-INA198 is exposed to transients on the inputs in excess of its ratings, then external transient absorption with semiconductor transient absorbers (zeners or Transzorbs) will be necessary. Use of MOVs or VDRs is not recommended except when they are used in addition to a semiconductor transient absorber. Select the transient absorber such that it will never allow the INA193-INA198 to be exposed to transients greater than +80V (that is, allow for transient absorber tolerance, as well as additional voltage due to transient absorber dynamic impedance). Despite the use of internal zener-type ESD protection, the INA193-INA198 does not lend itself to using external resistors in series with the inputs because the internal gain resistors can vary up to ±30%. (If gain accuracy is not important, then resistors can be added in series with the INA193-INA198 inputs with two equal resistors on each input.)

### **OUTPUT VOLTAGE RANGE**

The output of the INA193-INA198 is accurate within the output voltage swing range set by the power-supply pin, V+. This is best illustrated when using the INA195 or INA198 (which are both versions using a gain of 100), where a 100mV full-scale input from the shunt resistor requires an output voltage swing of +10V, and a power-supply voltage sufficient to achieve +10V on the output.



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### **RFI/EMI**

Attention to good layout practices is always recommended. Keep traces short and, when possible, use a printed circuit board (PCB) ground plane with surface-mount components placed as close to the device pins as possible. Small ceramic capacitors placed directly across amplifier inputs can reduce RFI/EMI sensitivity. PCB layout should locate the amplifier as far away as possible from RFI sources. Sources can include other components in the same system as the amplifier itself, such as inductors (particularly switched inductors handling a lot of current and at high frequencies). RFI can generally be identified as a variation in offset voltage or dc signal levels with changes in the interfering RF signal. If the amplifier cannot be located away from sources of radiation, shielding may be needed. Twisting wire input leads makes them more resistant to RF fields. The difference in input pin location of the INA193-INA195 versus the INA196-INA198 may provide different EMI performance.

### **INPUT FILTERING**

An obvious and straightforward location for filtering is at the output of the INA193-INA198; however, this location negates the advantage of the low output impedance of the internal buffer. The only other option for filtering is at the input pins of the INA193-INA198, which is complicated by the internal  $5k\Omega + 30\%$  input impedance; this is illustrated in Figure 22. Using the lowest possible resistor values minimizes both the initial shift in gain and effects of tolerance. The effect on initial gain is given by Equation 3:

GainError%=100 
$$-\left(\frac{5k\Omega}{5k\Omega + R_{FILT}}\right) \times 100$$
 (3)

Total effect on gain error can be calculated by replacing the  $5k\Omega$  term with  $5k\Omega - 30\%$ , (or  $3.5k\Omega$ ) or  $5k\Omega + 30\%$  (or  $6.5k\Omega$ ). The tolerance extremes of  $R_{FILT}$  can also be inserted into the equation. If a pair of  $100\Omega \ 1\%$  resistors are used on the inputs, the initial gain error will be approximately 2%. Worst-case tolerance conditions will always occur at the lower excursion of the internal  $5k\Omega$  resistor ( $3.5k\Omega$ ), and the higher excursion of  $R_{FILT} - 3\%$  in this case.

Note that the specified accuracy of the INA193-INA198 must then be combined in addition to these tolerances. While this discussion treated accuracy worst-case conditions by combining the extremes of the resistor values, it is appropriate to use geometric mean or root sum square calculations to total the effects of accuracy variations.

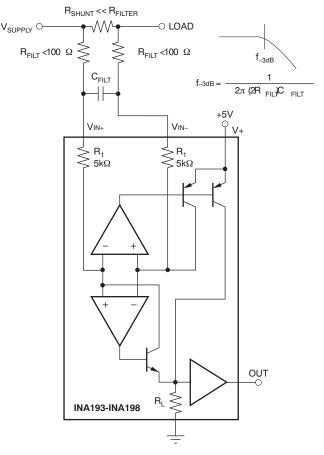


Figure 22. Input Filter (Gain Error – 1.5% to –2.2%)

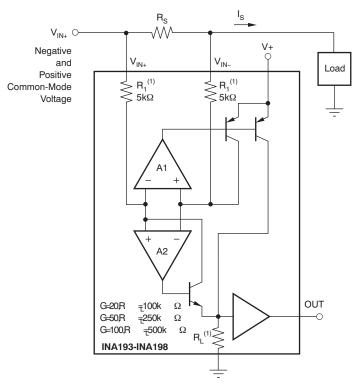
### **INSIDE THE INA193-INA198**

The INA193-INA198 uses a new, unique internal circuit topology that provides common-mode range extending from –16V to +80V while operating from a single power supply. The common-mode rejection in a classic instrumentation amplifier approach is limited by the requirement for accurate resistor matching. By converting the induced input voltage to a current, the INA193-INA198 provides common-mode rejection that is no longer a function of closely matched resistor values, providing the enhanced performance necessary for such a wide common-mode range. A simplified diagram (shown in Figure 23) shows the basic circuit function. When the common-mode voltage is positive, amplifier A2 is active.



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The differential input voltage,  $(V_{IN+}) - (V_{IN-})$  applied across  $R_S$ , is converted to a current through a resistor. This current is converted back to a voltage through  $R_L$ , and then amplified by the output buffer amplifier. When the common-mode voltage is negative, amplifier A1 is active. The differential input voltage,  $(V_{IN+}) - (V_{IN-})$  applied across  $R_S$ , is converted to a current through a resistor. This current is sourced from a precision current mirror whose output is directed into  $R_L$  converting the signal back into a voltage and amplified by the output buffer amplifier. Patent-pending circuit architecture ensures smooth device operation, even during the transition period where both amplifiers A1 and A2 are active.



(1) Nominal resistor values are shown. ±15% variation is possible. Resistor ratios are matched to ±1%.

Figure 23. INA193-INA198 Simplified Circuit Diagram



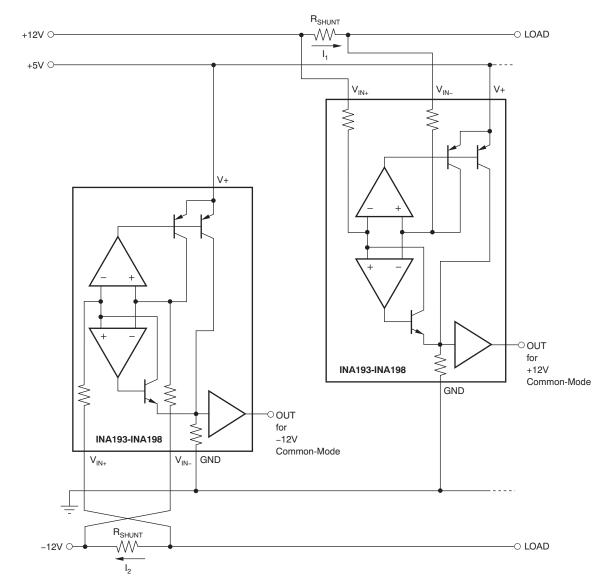
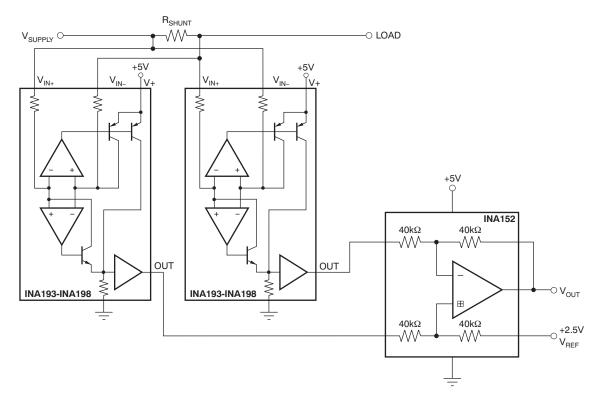


Figure 24. Monitor Bipolar Output Power-Supply Current







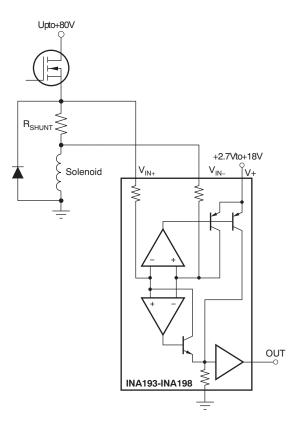


Figure 26. Inductive Current Monitor Including Flyback



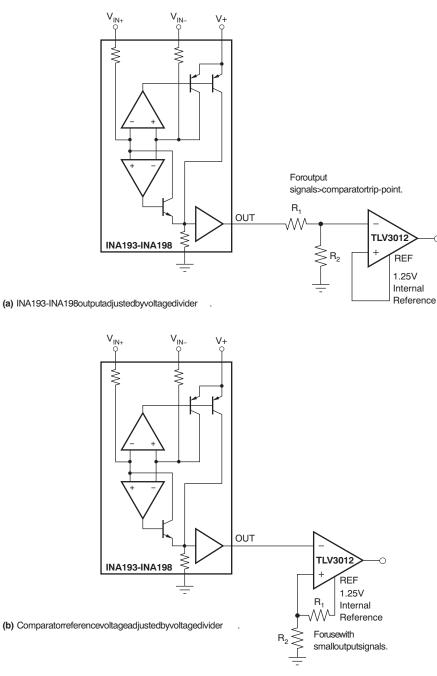


Figure 27. INA193-INA198 With Comparator



### **REVISION HISTORY**

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	Changes from Revision E (August 2006) to Revision F Page								
•	Updated document format to current standards	1							
•	Added test conditions to Output, Total Output Error parameter in Electrical Characteristics: V <sub>S</sub> = +12V	3							

7-Dec-2009

### **PACKAGING INFORMATION**

Orderable Device	Status <sup>(1)</sup>	Package Type	Package Drawing	Pins	Package Qty	e Eco Plan <sup>(2)</sup>	Lead/Ball Finish	MSL Peak Temp <sup>(3)</sup>
INA193AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA193AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA193AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA193AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA194AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA194AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA194AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA194AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA195AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA195AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA195AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA195AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA196AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA196AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA196AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA196AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA197AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA197AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA197AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA197AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA198AIDBVR	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA198AIDBVRG4	ACTIVE	SOT-23	DBV	5	3000	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA198AIDBVT	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR
INA198AIDBVTG4	ACTIVE	SOT-23	DBV	5	250	Green (RoHS & no Sb/Br)	CU NIPDAU	Level-2-260C-1 YEAR

 $^{(1)}$  The marketing status values are defined as follows:





7-Dec-2009

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

**OBSOLETE:** TI has discontinued the production of the device.

(2) Eco Plan - The planned eco-friendly classification: Pb-Free (RoHS), Pb-Free (RoHS Exempt), or Green (RoHS & no Sb/Br) - please check http://www.ti.com/productcontent for the latest availability information and additional product content details. TBD: The Pb-Free/Green conversion plan has not been defined.

Pb-Free (RoHS): TI's terms "Lead-Free" or "Pb-Free" mean semiconductor products that are compatible with the current RoHS requirements for all 6 substances, including the requirement that lead not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, TI Pb-Free products are suitable for use in specified lead-free processes.

Pb-Free (RoHS Exempt): This component has a RoHS exemption for either 1) lead-based flip-chip solder bumps used between the die and package, or 2) lead-based die adhesive used between the die and leadframe. The component is otherwise considered Pb-Free (RoHS compatible) as defined above.

Green (RoHS & no Sb/Br): TI defines "Green" to mean Pb-Free (RoHS compatible), and free of Bromine (Br) and Antimony (Sb) based flame retardants (Br or Sb do not exceed 0.1% by weight in homogeneous material)

<sup>(3)</sup> MSL, Peak Temp. -- The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

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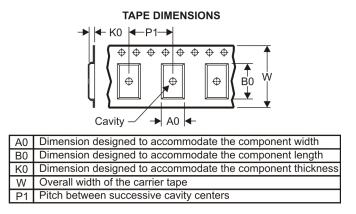
# PACKAGE MATERIALS INFORMATION

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### TAPE AND REEL INFORMATION





### QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



All dimensions are nomina	al											
Device	Package Type	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
INA193AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA193AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA194AIDBVR	SOT-23	DBV	5	3000	178.0	9.0	3.23	3.17	1.37	4.0	8.0	Q3
INA194AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA194AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA195AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA195AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA196AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA196AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA197AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA197AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA198AIDBVR	SOT-23	DBV	5	3000	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3
INA198AIDBVT	SOT-23	DBV	5	250	180.0	8.4	3.2	3.1	1.39	4.0	8.0	Q3

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# PACKAGE MATERIALS INFORMATION

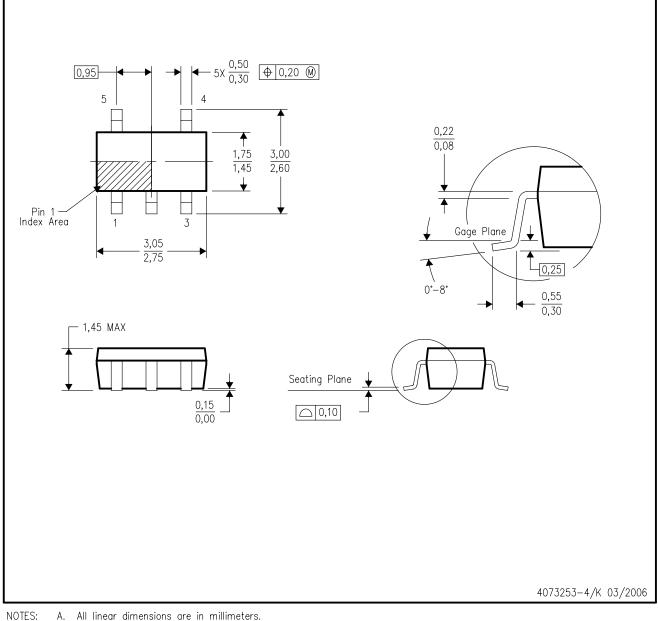
15-Apr-2011



*All dimensions are nominal							
Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
INA193AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA193AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8
INA194AIDBVR	SOT-23	DBV	5	3000	180.0	180.0	18.0
INA194AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA194AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8
INA195AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA195AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8
INA196AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA196AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8
INA197AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA197AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8
INA198AIDBVR	SOT-23	DBV	5	3000	190.5	212.7	31.8
INA198AIDBVT	SOT-23	DBV	5	250	190.5	212.7	31.8

DBV (R-PDSO-G5)

PLASTIC SMALL-OUTLINE PACKAGE



Α. All linear dimensions are in millimeters.

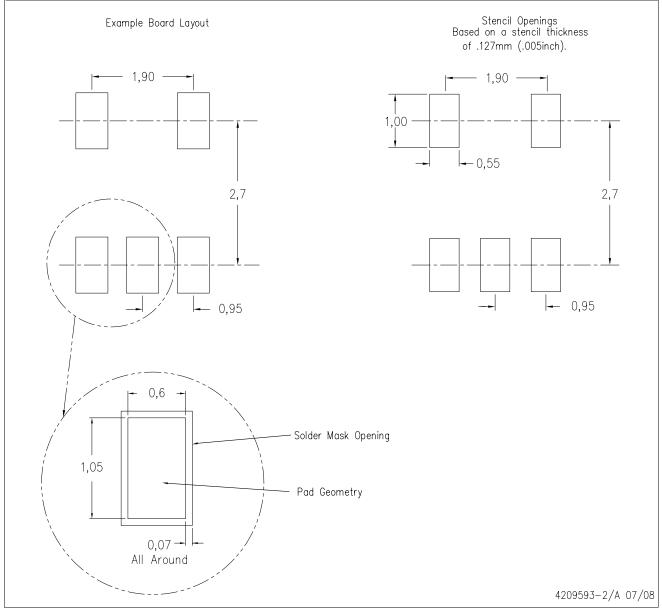
Β. This drawing is subject to change without notice.

Body dimensions do not include mold flash or protrusion. Mold flash and protrusion shall not exceed 0.15 per side. C.

D. Falls within JEDEC MO-178 Variation AA.



DBV (R-PDSO-G5)



NOTES:

- A. All linear dimensions are in millimeters.B. This drawing is subject to change without notice.
- C. Customers should place a note on the circuit board fabrication drawing not to alter the center solder mask defined pad.
- D. Publication IPC-7351 is recommended for alternate designs.
- E. Laser cutting apertures with trapezoidal walls and also rounding corners will offer better paste release. Customers should contact their board assembly site for stencil design recommendations. Example stencil design based on a 50% volumetric metal load solder paste. Refer to IPC-7525 for other stencil recommendations.



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